SCAN16602

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SCAN16602 Low Voltage Universal 16-bit IEEE 1149.1 Bus Transceiver with TRI-STATE Outputs

Check for Samples: SCAN16602

FEATURES

- IEEE 1149.1 (JTAG) Compliant
- 2.7V to 3.6V V_{CC} Operation
- TRI-STATE Outputs for Bus-Oriented Applications
- Dual Byte-Wide Data for Bus Applications
- Power Down High Impedance Inputs and Outputs
- Optional Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors (SCANH16602, SCANH162602 Versions)
- Optional 25Ω Series Resistors in Outputs to Minimize Noise and Eliminate Termination Resistors (SCAN162602, SCANH162602 Versions)
- Supports Live Insertion/Withdrawal
- Includes CLAMP and HIGHZ Instructions
- Extended Plastic Version Features:
 - Baseline Control Single Fab & Assembly Site
 - Process Change Notification (PCN)
 - Extended Temperature: -40°C to +125°C
 - Initial Qual & Reliability Data
 - Solder Lead Finish is Standard
 - DMS Management Support

DESCRIPTION

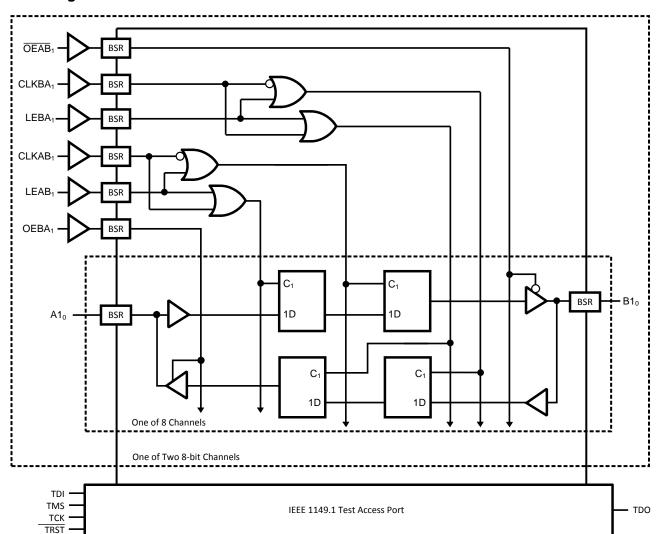
The SCAN16602 is a high speed, low-power universal bus transceiver featuring data inputs organized into two 8-bit bytes with separate output enable and latch enable control signals. The byte-wide output enable controls are complimentary to allow direction control with a single R/W line and no additional logic. This function is configurable as a D-type Latch or Flip-Flop, and can operate in transparent, latched, or clocked mode. This device is compliant with IEEE 1149.1 Standard Test Access Port and Boundary Scan Architecture with the incorporation of the defined boundary-scan test logic and test access port consisting of Test Data Input (TDI), Test Data Out (TDO), Test Mode Select (TMS), Test Clock (TCK), and Test Reset (TRST).

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Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



Block Diagram





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PIN DESCRIPTIONS

Pin Name	Description
A1 ₀ -A1 ₇ , A2 ₀ -A2 ₇	Normal-function A-bus I/O ports. See Function Table for A to B Data Flow and Function Table for B to A Data Flow for normal-mode logic.
B1 ₀ -B1 ₇ , B2 ₀ -B2 ₇	Normal-function B-bus I/O ports. See Function Table for A to B Data Flow and Function Table for B to A Data Flow for normal-mode logic.
CLKAB ₁ , CLKAB ₂ , CLKAB ₂	Normal-function clock inputs. See Function Table for A to B Data Flow and Function Table for B to A Data Flow for normal-mode logic.
GND	Ground
V _{CC}	Supply Voltage
LEAB ₁ , LEBA ₁ , LEAB ₂ , LEBA ₂	Normal-function latch enables. See Function Table for A to B Data Flow and Function Table for B to A Data Flow for normal-mode logic.
OEAB ₁ , OEAB ₂ , OEBA ₂	Normal-function output enables. See Function Table for A to B Data Flow and Function Table for B to A Data Flow for normal-mode logic.
TDO	The Test Data Output to support IEEE Std 1149.1-1990. TDO is the serial output for shifting data through the instruction register or selected data register.
TMS	The Test Mode Select input to support IEEE Std 1149.1-1990. TMS directs the device through it's TAP controller states. An internal pull-up forces TMS high if left unconnected.
TCK	The Test Clock input to support IEEE Std 1149.1-1990. Test operations of the device are synchronous to TCK. Data is captured on the rising edge of TCK and outputs change on the falling edge of TCK.
TDI	The Test Data Input to support IEEE Std 1149.1-1990. TDI is the serial input to shift data through the instruction register or the selected data register. An internal pull-up resistor forces TDI high if left unconnected.
TRST	The Test Reset Input to support IEEE Std 1149.1-1990. TRST is the asynchronous reset pin which will force the TAP controller to it's initialization state when active. An internal pullup resistor forces TRST high if left unconnected.

BGA Pinout

	1	2	3	4	5	6	7	8
Α	A1 ₀	A1 ₂	A1 ₄	A1 ₆	A2 ₀	A2 ₂	A2 ₄	A2 ₆
В	A1 ₁	A1 ₃	A1 ₅	A1 ₇	A2 ₁	A2 ₃	A2 ₅	A2 ₇
С	TRST	CLKAB ₁	LEAB ₁	OEAB ₁	GND	CLKAB ₂	LEAB ₂	OEAB ₂
D	TMS	GND	V _{CC}	GND	V _{CC}	GND	TDI	TDO
E	TCK	GND	V _{CC}	V _{CC}	GND	GND	N/C	V _{CC}
F	CLKBA ₁	LEBA ₁	OEBA ₁	GND	N/C	CLKBA ₂	LEBA ₂	OEBA ₂
G	B1 ₁	B1 ₃	B1 ₅	B1 ₇	B2 ₁	B2 ₃	B2 ₅	B2 ₇
Н	B1 ₀	B1 ₂	B1 ₄	B1 ₆	B2 ₀	B2 ₂	B2 ₄	B2 ₆

Product Folder Links: SCAN16602



Connection Diagram

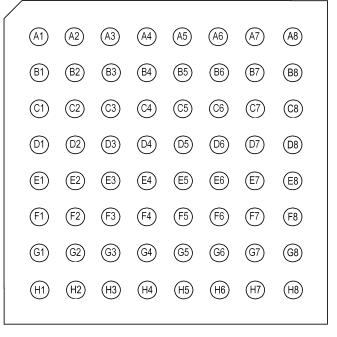


Figure 1. Top View

Function Table for A to B Data Flow⁽¹⁾

	Inputs						
OEAB	LEAB	CLKAB	Α	В			
L	L	L	Х	B ₀ ⁽²⁾			
L	L	↑	L	L			
L	L	↑	Н	Н			
L	Н	Х	L	L			
L	Н	Х	Н	Н			
Н	X	Х	X	Z			

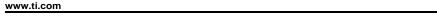
(1) H = HIGH Voltage Level

L = LOW Voltage Level

X = Immaterial (HIGH or LOW, inputs may not float)

Z = High Impedance

(2) Output level before the indicated steady-state input conditions were established.



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	Inputs					
OEBA	LEBA	CLKBA	В	Α		
Н	L	L	X	A ₀ ⁽²⁾		
Н	L	↑	L	L		
Н	L	↑	Н	Н		
Н	Н	Х	L	L		
Н	Н	Х	Н	Н		
L	X	Х	Χ	Z		

- (1) H = HIGH Voltage Level
 - L = LOW Voltage Level
 - X = Immaterial (HIGH or LOW, inputs may not float)

Function Table for B to A Data Flow(1)

- Z = High Impedance
- (2) Output level before the indicated steady-state input conditions were established.

Functional Description

In the normal mode, these devices are 16-bit universal bus transceivers that combine D-type latches and D-type flip-flops to allow data flow in transparent, latched, or clocked modes. They can be used as two 8-bit transceivers, or as one 16-bit transceiver. The test circuitry can be activated by the TAP to take snapshot samples of the data appearing at the device pins or to perform a self test on the boundary-test cells. Activating the TAP may affect the normal functional operation of the universal bus transceivers. When the TAP is activated, the test circuitry performs boundary-scan test operations according to the protocol described in IEEE Std 1149.1-1990.

Data flow in each direction is controlled by output-enable (OEAB and OEBA), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. For A-to-B data flow, the devices operate in the transparent mode when LEAB is high. When LEAB is low, the A data is latched while CLKAB is held at a static low or high logic level. Otherwise, if LEAB is low, A data is stored on a low-to-high transition of CLKAB. When OEAB is LOW, the B outputs are active. When OEAB is HIGH, the B outputs are in the high-impedance state. B-to-A data flow is similar to A-to-B data flow but uses the OEBA, LEBA, and CLKBA inputs. The output enables are complimentary to facilitate the use of a single R/W signal without additional logic.

Five dedicated test pins are used to observe and control the operation of the test circuitry: test data input (TDI), test data output (TDO), test mode select (TMS), test clock (TCK), and test reset (TRST). All testing and scan operations are synchronized to the TAP interface.

For details about the sequence of boundary scan cells in the SCAN16602, please refer to the BSDL (Boundary Scan Description Language) file available on our website at http://www.ti.com/lsds/ti/analog/interface.page.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Product Folder Links: SCAN16602



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Absolute Maximum Ratings(1)

Supply Voltage (V _{CC})		-0.5V to +4.6V
DC Input Diode Current (I _{IK})	V _I = −0.5V	−50 mA
DC Output Diode Current (I _{OK})	$V_{O} = -0.5V$	−50 mA
DC Input Voltage (V _I)		-0.5V to 4.6V
DC Output Voltage (V _O)		-0.5V to 4.6V
DC Output Source/Sink Current (I _O)		±50 mA
DC V _{CC} or Ground Current per Supply F	in	±100 mA
Junction Temperature		+150°C
Storage Temperature		−65°C to +150°C
Lead Temperature (Solder, 4sec)	64L BGA	220 °C
Thermal Resistance	BGA θ_{JA}	62°C/W
Package Derating	· ·	16.1mW/°C above 25°C
ESD (Min)	·	2000V

⁽¹⁾ Absolute maximum ratings are those values beyond which damage to the device may occur.

Recommended Operating Conditions

·		
Supply Voltage (V _{CC})	SCAN16602	2.7V to 3.6V
Input Voltage (V _I)	·	0V to 3.6V
Output Voltage (V _O)		0V to 3.6V
Operating Temperature (T _A)	Industrial	−40°C to +85°C
	Extended Plastic	-40°C to +125°C

DC Electrical Characteristics

	Parameter		Industrial T _A = -40°C to +85°C		Extended Plastic T _A = -40°C to +125°C			Conditions
Symbol		V _{CC} (V)					Units	
		(•)	Min	Max	Min	Max		
V _{IH}	Minimum High Input Voltage	2.7	2.0				V	V _{OUT} = 0.1V
		3.6	2.0					or V _{CC} −0.1V
V _{IL}	Maximum Low Input Voltage	2.7		0.8			V	V _{OUT} = 0.1V
		3.6		0.8				or V _{CC} -0.1V
V _{OH}	Minimum High Output Voltage All Outputs, All Options	2.7	2.5				V	I _{OUT} = -100 μA
		3.6	3.4					
	Minimum High Output Voltage TDO Outputs, All Options	2.7	2.2				V	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -12\text{mA}$
		3.0	2.2				V	$V_{IN} = V_{IL} \text{ or } V_{IH}$ $I_{OH} = -24\text{mA}$
	Minimum High Output Voltage A and B Ports: SCAN16602 and SCANH16602 options	2.7	2.2				V	$V_{IN} = V_{IL} \text{ or } V_{IH}$ $I_{OH} = -12\text{mA}$
		3.0	2.2				V	$V_{IN} = V_{IL} \text{ or } V_{IH}$ $I_{OH} = -24\text{mA}$
	Minimum High Output Voltage A and B Ports: SCAN162602 and	2.7	2.2				V	$V_{IN} = V_{IL} \text{ or } V_{IH}$ $I_{OH} = -4\text{mA}$
	SCANH162602 options (25 Ω series resistor options)	3.0	2.2				V	$V_{IN} = V_{IL} \text{ or } V_{IH}$ $I_{OH} = -12\text{mA}$

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DC Electrical Characteristics (continued)

	Parameter		Indu	strial	Extende	ed Plastic		
Symbol		V _{CC}	T _A = -40°C to +85°C		$T_A = -40^{\circ}C \text{ to } +125^{\circ}C$		Units	Conditions
		(*)	Min	Max	Min	Max		
V _{OL}	Maximum Low Output Voltage	2.7		0.2			V	I _{OUT} = 100 μA
	All Outputs, All Options	3.6		0.2				
	Maximum Low Output Voltage TDO Outputs, All Options	2.7		0.4			V	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 12\text{mA}$
		3.0		0.55			V	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}$
	Maximum Low Output Voltage A and B Ports: SCAN16602 and	2.7		0.4			V	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 12\text{mA}$
	SCANH16602 Options	3.0		0.55			V	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}$
	Maximum Low Output Voltage A and B Ports: SCAN162602 and	2.7		0.4			V	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 4\text{mA}$
	SCANH162602 Options (25 Ω series resistor options)	3.0		0.6			V	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 12\text{mA}$
I _{IN}	Maximum Input Leakage Current	3.6		±5.0			μΑ	$V_I = V_{CC}$, GND
I _{ILR}	Input Low Current	3.6	-20	-250			μΑ	V _{IN} = GND
l _{OZ}	Maximum I/O Leakage Current	3.6		±10.0			μA	V_{I} (OE) = V_{IL} , V_{IH} V_{I} = V_{CC} , GND V_{O} = V_{CC} , GND
I _{I(HOLD)}	Bus Hold Input Minimum Drive Hold	2.7	±35				μΑ	V _I = 0.8V or 2.0V
	Current ⁽¹⁾	3.6		±500				$V_{I} = 0 \text{ to } 3.6V$
V_{IKL}	Input Clamp Diode Voltage	2.7		-1.5			V	I _{IN} = −18mA
I _{OFF}	Power-off Leakage Current	0.0		±10.0			μΑ	$V_O = V_{CC}$, GND
I _{CC}	Maximum Quiescent Supply Current	3.6		20			μA	
I _{CCt}	Maximum I _{CC} Per Input	3.6		0.5			mA	$V_I = V_{CC} - 0.6V$

⁽¹⁾ Applies to devices with Bus Hold feature only.

Noise Specifications

Applies to SCAN16602 and SCANH16602 options, C_L = 30pF, R_L = 500 Ω to GND

			Industrial	Extended Plastic	
Symbol	Parameter	V _{CC} (V)	T _A = 25°C	T _A = 25°C	Units
		(*)	Typical Limits		
V_{OLP}	Quiet Output Maximum Dynamic VOL ⁽¹⁾	3.3	1.2		V
V _{OLV}	Quiet Output Minimum Dynamic VOL ⁽¹⁾	3.3	-1.5		V
V _{OHP}	Quiet Output Maximum Dynamic VOH(2)	3.3	VOH + 0.9		V
V _{OHV}	Quiet Output Minimum Dynamic VOH(2)	3.3	VOH - 1.5		V

⁽¹⁾ Maximum number of outputs is defined as n. (n-1) outputs are switched LOW while the quiet output is monitored in a LOW (VOL) state.

Also, (n-1) outputs are switched HIGH while the quiet output is monitored in a LOW (VOL) state.

⁽²⁾ Maximum number of outputs is defined as n. (n-1) outputs are switched LOW while the quiet output is monitored in a HIGH (VOH) state. Also, (n-1) outputs are switched HIGH while the quiet output is monitored in a HIGH (VOH) state.

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Noise Specifications

Applies to SCAN162602 and SCANH162602 options, $C_L = 30pF$, $R_L = 500\Omega$ to GND

			Industrial	Extended Plastic	
Symbol	Parameter	V _{CC} (V)	T _A = 25°C	T _A = 25°C	Units
		(*)	Typical Limits		
V _{OLP}	Quiet Output Maximum Dynamic VOL ⁽¹⁾	3.3	0.5		V
V _{OLV}	Quiet Output Minimum Dynamic VOL ⁽¹⁾	3.3	-0.4		V
V _{OHP}	Quiet Output Maximum Dynamic VOH ⁽²⁾	3.3	VOH + 0.5		V
V _{OHV}	Quiet Output Minimum Dynamic VOH(2)	3.3	VOH - 0.5		V

⁽¹⁾ Maximum number of outputs is defined as n. (n-1) outputs are switched LOW while the quiet output is monitored in a LOW (VOL) state. Also, (n-1) outputs are switched HIGH while the quiet output is monitored in a LOW (VOL) state.

AC Electrical Characteristics

Normal Operation, over recommended operating supply voltage and temperature ranges unless otherwise specified.

	SCA	N16602, SCAN	H16602		
Symbol		Indu	strial	Extended Plastic	
	Parameter	. C _L =	C to +85°C 30pF Ω to GND	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ $C_L = 30\text{pF}$ $R_L = 500\Omega \text{ to GND}$	Units
		Min	Max		
t _{PLH} ,	Propagation Delay		5.5		ns
t _{PHL}	A to B, B to A		5.5		
t _{PLH} ,	Propagation Delay		6.0		ns
t _{PHL}	CLKAB to B, CLKBA to A		6.0		
t _{PLH} ,	Propagation Delay		6.0		ns
t _{PHL}	LEAB to B, LEBA to A		6.0		
t _{PLZ} ,	Disable Time, OEAB to B, OEBA to A		7.5		ns
t _{PHZ}			7.5		
t _{PZL} ,	Enable Time, OEAB to B, OEBA to A		7.5		ns
t _{PZH}			7.5		

AC Electrical Characteristics

Normal Operation, over recommended operating supply voltage and temperature ranges unless otherwise specified.

		SCAN162602				
Symbol	Parameter	Indu	strial	Extende	d Plastic	
		$T_A = -40^{\circ}$ $C_L = R_L = 5009$		$T_A = -40$ °C to +125°C $C_L = 30$ pF $R_L = 500\Omega$ to GND		Units
		Min	Max	Min	Max	
t _{PLH} ,	Propagation Delay		6.0	1		ns
t _{PHL}	A to B, B to A		6.0			
t _{PLH} ,	Propagation Delay		6.5			ns
t _{PHL}	CLKAB to B, CLKBA to A		6.5			
t _{PLH} ,	Propagation Delay		6.5			ns
t _{PHL}	LEAB to B, LEBA to A		6.5			
t _{PLZ} ,	Disable Time, OEAB to B, OEBA to A		8.0			ns
t _{PHZ}			8.0			
t _{PZL} ,	Enable Time, OEAB to B, OEBA to A		8.0			ns
t _{PZH}			8.0			

⁽²⁾ Maximum number of outputs is defined as n. (n-1) outputs are switched LOW while the quiet output is monitored in a HIGH (VOH) state.

Also, (n-1) outputs are switched HIGH while the quiet output is monitored in a HIGH (VOH) state.

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AC Electrical Characteristics

Normal Operation, over recommended operating supply voltage and temperature ranges unless otherwise specified.

		SCANH16260	2			
Symbol	Parameter	Industrial $T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ $C_L = 30\text{pF}$ $R_L = 500\Omega \text{ to GND}$		Extended Plastic $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ $C_L = 30\text{pF}$ $R_L = 500\Omega \text{ to GND}$		Units
		t _{PLH} ,	Propagation Delay		6.0	
t _{PHL}	A to B, B to A		6.0			
t _{PLH} ,	Propagation Delay		6.5			ns
t _{PHL}	CLKAB to B, CLKBA to A		6.5			
t _{PLH} ,	Propagation Delay		6.5			ns
t _{PHL}	LEAB to B, LEBA to A		6.5			
t _{PLZ} ,	Disable Time, OEAB to B, OEBA to A		8.0			ns
t_{PHZ}			8.0			
t _{PZL} ,	Enable Time, OEAB to B, OEBA to A		8.0			ns
t_{PZH}			8.0			

AC Operating Requirements

Normal Operation, over recommended operating supply voltage and temperature ranges unless otherwise specified

Symbol		Industrial	Extended Plastic	Units
		T _A = -40°C to +85°C	T _A = -40°C to +125°C	
	Parameter	$C_L = 30 \text{ pF},$ $R_L = 500\Omega \text{ to GND}$	$C_L = 30 \text{ pF},$ $R_L = 500\Omega \text{ to GND}$	
		Ensured Minimum	Ensured Minimum	
t _S	Setup Time, A to CLKAB or B to CLKBA	1.5		ns
t _H	Hold Time, A to CLKAB or B to CLKBA	2.0		ns
t _S	Setup Time, A to LEAB or B to LEBA	1.5		ns
t _H	Hold Time, A to LEAB or B to LEBA	2.5		ns
t _W	Pulse Width, CLKAB or CLKBA, high or low	2.0		ns
t _W	Pulse Width, LEAB or LEBA high	2.0		ns
f _{max}	Maximum CLKAB or CLKBA Clock Frequency	250		MHz

AC Operating Requirements

can Test Operation, over recommended operating supply voltage and temperature ranges unless otherwise specified

Symbol		Industrial	Extended Plastic	Units
		T _A = -40°C to +85°C	T _A = -40°C to +125°C	
	Parameter	$C_L = 30 \text{ pF},$ $R_L = 500\Omega \text{ to GND}$	$C_L = 30 \text{ pF},$ $R_L = 500\Omega \text{ to GND}$	
		Ensured Minimum	Ensured Minimum	
t _S	Setup Time, H or L, TMS to TCK	2.0		ns
ŀн	Hold Time, H or L, TCK to TMS	1.0		ns
ts	Setup Time, H or L, TDI to TCK	1.0		ns
^t н	Hold Time, H or L, TCK to TDI	2.0		ns
W	Pulse Width TCK High or Low	10		ns
tw	Pulse Width TRST, Low	2.5		ns
: max	Maximum TCK Clock Frequency	25		MHz
t _{REC}	Recovery Time, TRST to TCK	2.0		ns

Product Folder Links: SCAN16602



Capacitance and I/O Characteristics

Refer to TI's website for IBIS models at www.ti.com/lsds/ti/analog/interface.page

Table 1. Device ID Register

Ordering Code	Features	Device ID	Manufacturer & LSB
SCAN16602SM	No bus hold, no series resistor	FC30	01F
SCANH16602SM	With bus hold only	FC31	01F
SCAN162602SM	With 25Ω series resistors in outputs	FC32	01F
SCANH162602SM	With 25Ω series resistors and bus hold	FC33	01F

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REVISION HISTORY

Changes from Revision B (April 2013) to Revision C			
•	Changed layout of National Data Sheet to TI format	1	10

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Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

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